

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10814547	HAILEY ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	Faber, David	2178

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
715	500.1, 513-515	1/9/2008	

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
EAST (Search Notes Attached)	1/9/2008	
Consulted with Primary Examiner William Bashore	1/9/2008	

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>